Small Signal MOSFET

20 V, 540 mA, Dual N-Channel

Features

- Low R_{DS(on)} Improving System Efficiency
- Low Threshold Voltage
- Small Footprint 1.6 x 1.6 mm
- ESD Protected Gate
- These are Pb-Free Devices

Applications

- Load/Power Switches
- Power Supply Converter Circuits
- Battery Management
- Cell Phones, Digital Cameras, PDAs, Pagers, etc.

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted.)

Paramet	Symbol	Value	Unit		
Drain-to-Source Voltage	V _{DSS}	20	V		
Gate-to-Source Voltage			V_{GS}	±6.0	V
Continuous Drain Current	Steady T _A = 25°C			540	mA
(Note 1)	State	$T_A = 85^{\circ}C$	ID	390	
Power Dissipation (Note 1)	Steady State		P _D	250	mW
Continuous Drain Current	11.5.10		I _D	570	mA
(Note 1)	1 ≥ 3 5	$T_A = 85^{\circ}C$		410	
Power Dissipation (Note 1)	t:	≤ 5 s	P _D	280	mW
Pulsed Drain Current	ulsed Drain Current $t_p = 10 \mu s$			1.5	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
Source Current (Body Diode)			Is	350	mA
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{ hetaJA}$	500	°C/W
$Junction-to-Ambient - t \le 5 s \text{ (Note 1)}$		447	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

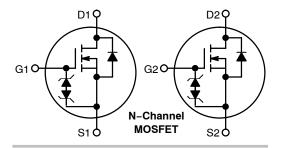
1. Surface mounted on FR4 board using 1 in sq pad size (Cu. area = 1.127 in sq [1 oz] including traces).



ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} Typ	I _D Max (Note 1)		
20	400 mΩ @ 4.5 V			
	500 mΩ @ 2.5 V	540 mA		
	700 mΩ @ 1.8 V			





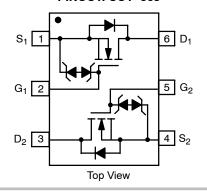
MARKING DIAGRAM

= Pb-Free Package

TV = Specific Device Code M = Date Code

(Note: Microdot may be in either location)

PINOUT: SOT-563



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 4 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted.)

Parameter	Symbol	Test Condition			Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		20	_	_	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	-		-	14	_	mV/°C
Zero Gate Voltage Drain Current		V _{GS} = 0 V	T _J = 25°C	-	-	1.0	μΑ
	IDEC 14 121	T _J = 125°C	-	_	5.0		
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4$	1.5 V	-	_	±5.0	μΑ
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250$) μΑ	0.45	_	1.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	-		-	2.0	_	mV/°C
Drain-to-Source On Resistance		$V_{GS} = 4.5 \text{ V}, I_D = 540$) mA	-	0.4	0.55	Ω
	R _{DS(on)}	V _{GS} = 2.5 V, I _D = 500) mA	-	0.5	0.7	
		V _{GS} = 1.8 V, I _D = 350 mA			0.7	0.9	
Forward Transconductance	9FS	V _{DS} = 10 V, I _D = 540	mA	-	1.0	_	S
CHARGES AND CAPACITANCES	•						
Input Capacitance	C _{ISS}			-	80	150	pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 16 V			13	25	
Reverse Transfer Capacitance	C _{RSS}				10	20	
Total Gate Charge	Q _{G(TOT)}			-	1.5	2.5	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 10 V; I _D = 540 mA		-	0.1	_	
Gate-to-Source Charge	Q _{GS}			-	0.2	_	
Gate-to-Drain Charge	Q_{GD}				0.35	_	
SWITCHING CHARACTERISTICS, V _{GS} = V (Note 4)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DD} = 10 V, I_{D} = 540 mA, R_{G} = 10 Ω		-	6.0	_	ns
Rise Time	t _r			-	4.0	_	
Turn-Off Delay Time	t _{d(OFF)}			-	16	_	
Fall Time	t _f				8.0	-	
DRAIN-SOURCE DIODE CHARACTERISTIC	s	•					
Forward Diode Voltage		V _{GS} = 0 V,	T _J = 25°C	-	0.7	1.2	V
	V_{SD}	I _S = 350 mA	T _J = 125°C	-	0.6	-	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, d_{ISD}/d_t = 100 \text{ A}/\mu\text{s}, I_S = 350 \text{ mA}$		-	6.5	-	ns

Surface-mounted on FR4 board using 1 in. sq. pad size (Cu. area = 1.127 in sq [1 oz] including traces).
Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

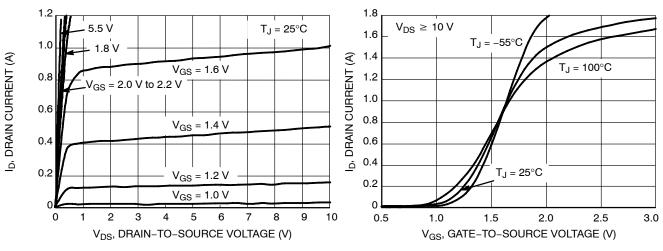


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

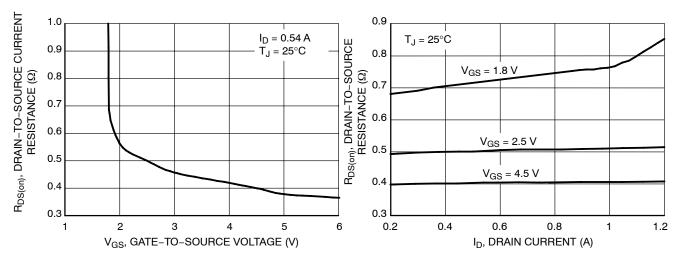


Figure 3. On-Resistance versus Gate-to-Source Voltage

Figure 4. On-Resistance versus Drain Current and Gate Voltage

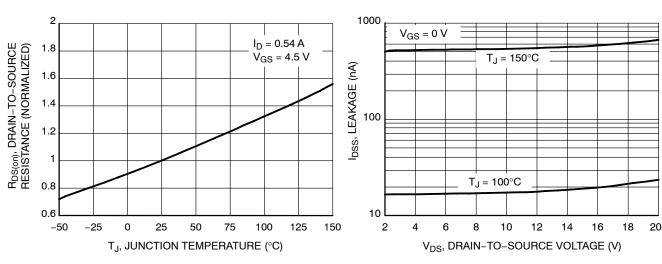
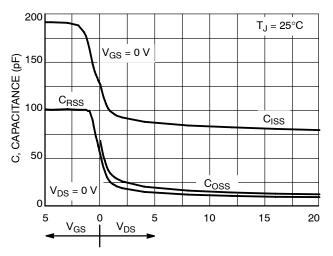
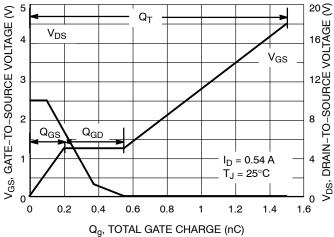


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current versus Voltage

TYPICAL PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)

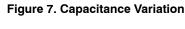


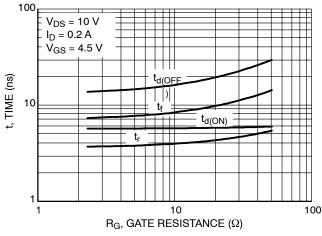


GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

GE (V)

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge





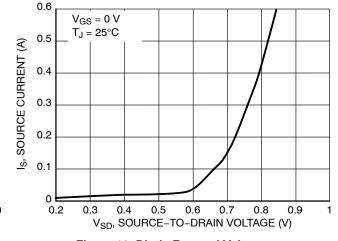


Figure 9. Resistive Switching Time Variation versus Gate Resistance

Figure 10. Diode Forward Voltage versus Current

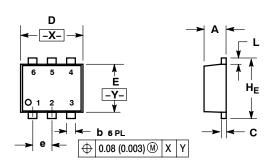
ORDERING INFORMATION

Device	Package	Shipping
NTZD3154NT1G	SOT-563 (Pb-Free)	4000 / Tape & Reel
NTZD3154NT5G	SOT-563 (Pb-Free)	8000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

SOT-563, 6 LEAD CASE 463A-01 **ISSUE F**

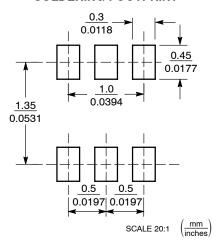


NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETERS
- MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.50	0.55	0.60	0.020	0.021	0.023	
b	0.17	0.22	0.27	0.007	0.009	0.011	
С	0.08	0.12	0.18	0.003	0.005	0.007	
D	1.50	1.60	1.70	0.059	0.062	0.066	
Е	1.10	1.20	1.30	0.043	0.047	0.051	
Ф	0.5 BSC			0.02 BSC			
L	0.10	0.20	0.30	0.004	0.008	0.012	
HE	1.50	1.60	1.70	0.059	0.062	0.066	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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